

PQ Protocol



Company: Moscow State University of
Operator: Default
Instrument Type: Senterra Microscope 785 nm Grating 400
Optics Configuration: Microscope with: 785 nm, Grating 400, CCD
Accessory: None
Instrument Serial Number: Result
Instrument Firmware Version:
OPUS/DB Version: 20090227 / 6.5.9
Overall Test Result: PASS
Test expires: 2013/01/18 18:42:49
Test Date/Time: 2012/01/18 18:42:49
Test Spectra Path: C:\Program Files\OPUS_65\Validation\Data\20120118\184249
Comment:

Photometric Consistency Test

1. Peak specified:	620.9 cm⁻¹	1. Peak measured:	620.5 cm⁻¹
Max. Deviation Limit:	10.000 %	Measured Deviation:	0.601 %
2. Peak specified:	1001.4 cm⁻¹	2. Peak measured:	1001.1 cm⁻¹
Max. Deviation Limit:	10.000 %	Measured Deviation:	0.000 %
3. Peak specified:	1602.3 cm⁻¹	3. Peak measured:	1602.2 cm⁻¹
Max. Deviation Limit:	10.000 %	Measured Deviation:	3.741 %
4. Peak specified:	Not determined.	4. Peak measured:	Not determined.
Max. Deviation Limit:	---	Measured Deviation:	---
5. Peak specified:	Not determined.	5. Peak measured:	Not determined.
Max. Deviation Limit:	---	Measured Deviation:	---

Overall Test Result = PASS



Date and Signature

Date and Signature